

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10542910	ZHOU ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	JASON M MANDEVILLE	2629

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	107	06 June 2008	Jason Mandeville
359	296	06 June 2008	Jason Mandeville
345	107	12/04/2008	Jason Mandeville
359	296	12/04/2008	Jason Mandeville

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	06 June 2008	Jason Mandeville	
Inventor Search	06 June 2008	Jason Mandeville	
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	12/04/2008	Jason Mandeville	
Inventor Search	12/04/2008	Jason Mandeville	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/J. M. M./  
Examiner Art Unit 2629